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### Understanding [Embedded - Microprocessors](#)

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

### Applications of [Embedded - Microprocessors](#)

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

#### Details

Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.2GHz
Co-Processors/DSP	Signal Processing; SPE, Security; SEC
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8545evjatgd">https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8545evjatgd</a>

- Up to 32 simultaneous open pages for DDR2
- Contiguous or discontiguous memory mapping
- Read-modify-write support for RapidIO atomic increment, decrement, set, and clear transactions
- Sleep mode support for self-refresh SDRAM
- On-die termination support when using DDR2
- Supports auto refreshing
- On-the-fly power management using CKE signal
- Registered DIMM support
- Fast memory access via JTAG port
- 2.5-V SSTL\_2 compatible I/O (1.8-V SSTL\_1.8 for DDR2)
- Support for battery-backed main memory
- Programmable interrupt controller (PIC)
  - Programming model is compliant with the OpenPIC architecture.
  - Supports 16 programmable interrupt and processor task priority levels
  - Supports 12 discrete external interrupts
  - Supports 4 message interrupts with 32-bit messages
  - Supports connection of an external interrupt controller such as the 8259 programmable interrupt controller
  - Four global high-resolution timers/counters that can generate interrupts
  - Supports a variety of other internal interrupt sources
  - Supports fully nested interrupt delivery
  - Interrupts can be routed to external pin for external processing.
  - Interrupts can be routed to the e500 core's standard or critical interrupt inputs.
  - Interrupt summary registers allow fast identification of interrupt source.
- Integrated security engine (SEC) optimized to process all the algorithms associated with IPSec, IKE, WTLS/WAP, SSL/TLS, and 3GPP
  - Four crypto-channels, each supporting multi-command descriptor chains
    - Dynamic assignment of crypto-execution units via an integrated controller
    - Buffer size of 256 bytes for each execution unit, with flow control for large data sizes
  - PKEU—public key execution unit
    - RSA and Diffie-Hellman; programmable field size up to 2048 bits
    - Elliptic curve cryptography with  $F_2m$  and  $F(p)$  modes and programmable field size up to 511 bits
  - DEU—Data Encryption Standard execution unit
    - DES, 3DES
    - Two key (K1, K2) or three key (K1, K2, K3)
    - ECB and CBC modes for both DES and 3DES

- Memory prefetching of PCI read accesses
- Supports posting of processor-to-PCI and PCI-to-memory writes
- PCI 3.3-V compatible
- Selectable hardware-enforced coherency
- Serial RapidIO™ interface unit
  - Supports *RapidIO™ Interconnect Specification, Revision 1.2*
  - Both 1× and 4× LP-serial link interfaces
  - Long- and short-haul electricals with selectable pre-compensation
  - Transmission rates of 1.25, 2.5, and 3.125 Gbaud (data rates of 1.0, 2.0, and 2.5 Gbps) per lane
  - Auto detection of 1- and 4-mode operation during port initialization
  - Link initialization and synchronization
  - Large and small size transport information field support selectable at initialization time
  - 34-bit addressing
  - Up to 256 bytes data payload
  - All transaction flows and priorities
  - Atomic set/clr/inc/dec for read-modify-write operations
  - Generation of IO\_READ\_HOME and FLUSH with data for accessing cache-coherent data at a remote memory system
  - Receiver-controlled flow control
  - Error detection, recovery, and time-out for packets and control symbols as required by the RapidIO specification
  - Register and register bit extensions as described in part VIII (Error Management) of the RapidIO specification
  - Hardware recovery only
  - Register support is not required for software-mediated error recovery.
  - Accept-all mode of operation for fail-over support
  - Support for RapidIO error injection
  - Internal LP-serial and application interface-level loopback modes
  - Memory and PHY BIST for at-speed production test
- RapidIO-compatible message unit
  - 4 Kbytes of payload per message
  - Up to sixteen 256-byte segments per message
  - Two inbound data message structures within the inbox
  - Capable of receiving three letters at any mailbox
  - Two outbound data message structures within the outbox
  - Capable of sending three letters simultaneously
  - Single segment multicast to up to 32 devIDs
  - Chaining and direct modes in the outbox

- Single inbound doorbell message structure
- Facility to accept port-write messages
- PCI Express interface
  - PCI Express 1.0a compatible
  - Supports x8, x4, x2, and x1 link widths
  - Auto-detection of number of connected lanes
  - Selectable operation as root complex or endpoint
  - Both 32- and 64-bit addressing
  - 256-byte maximum payload size
  - Virtual channel 0 only
  - Traffic class 0 only
  - Full 64-bit decode with 32-bit wide windows
- Pin multiplexing for the high-speed I/O interfaces supports one of the following configurations:
  - 8 PCI Express
  - 4 PCI Express and 4 serial RapidIO
- Power management
  - Supports power saving modes: doze, nap, and sleep
  - Employs dynamic power management, which automatically minimizes power consumption of blocks when they are idle
- System performance monitor
  - Supports eight 32-bit counters that count the occurrence of selected events
  - Ability to count up to 512 counter-specific events
  - Supports 64 reference events that can be counted on any of the eight counters
  - Supports duration and quantity threshold counting
  - Burstiness feature that permits counting of burst events with a programmable time between bursts
  - Triggering and chaining capability
  - Ability to generate an interrupt on overflow
- System access port
  - Uses JTAG interface and a TAP controller to access entire system memory map
  - Supports 32-bit accesses to configuration registers
  - Supports cache-line burst accesses to main memory
  - Supports large block (4-Kbyte) uploads and downloads
  - Supports continuous bit streaming of entire block for fast upload and download
- JTAG boundary scan, designed to comply with IEEE Std. 1149.1™

### NOTE

From a system standpoint, if any of the I/O power supplies ramp prior to the  $V_{DD}$  core supply, the I/Os associated with that I/O supply may drive a logic one or zero during power-up, and extra current may be drawn by the device.

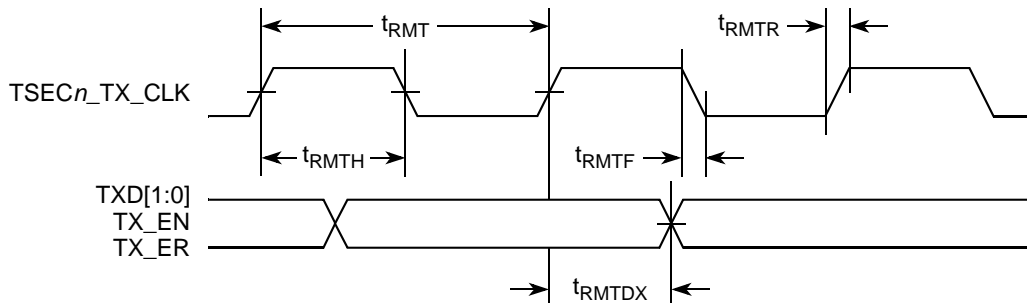
**Table 34. RMII Transmit AC Timing Specifications (continued)**

Parameter/Condition	Symbol <sup>1</sup>	Min	Typ	Max	Unit
TSEC <sub>n</sub> _TX_CLK to RMII data TXD[1:0], TX_EN delay	$t_{\text{RMTDX}}$	1.0	—	10.0	ns

**Note:**

1. The symbols used for timing specifications follow the pattern of  $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$  for inputs and  $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$  for outputs. For example,  $t_{\text{MTKHX}}$  symbolizes MII transmit timing (MT) for the time  $t_{\text{MTX}}$  clock reference (K) going high (H) until data outputs (D) are invalid (X). Note that, in general, the clock reference symbol representation is based on two to three letters representing the clock of a particular functional. For example, the subscript of  $t_{\text{MTX}}$  represents the MII(M) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

Figure 18 shows the RMII transmit AC timing diagram.

**Figure 18. RMII Transmit AC Timing Diagram**

### 8.2.7.2 RMII Receive AC Timing Specifications

**Table 35. RMII Receive AC Timing Specifications**

Parameter/Condition	Symbol <sup>1</sup>	Min	Typ	Max	Unit
TSEC <sub>n</sub> _TX_CLK clock period	$t_{\text{RMR}}$	15.0	20.0	25.0	ns
TSEC <sub>n</sub> _TX_CLK duty cycle	$t_{\text{RMRH}}$	35	50	65	%
TSEC <sub>n</sub> _TX_CLK peak-to-peak jitter	$t_{\text{RMRJ}}$	—	—	250	ps
Rise time TSEC <sub>n</sub> _TX_CLK(20%–80%)	$t_{\text{RMRR}}$	1.0	—	2.0	ns
Fall time TSEC <sub>n</sub> _TX_CLK (80%–20%)	$t_{\text{RMRF}}$	1.0	—	2.0	ns
RXD[1:0], CRS_DV, RX_ER setup time to REF_CLK rising edge	$t_{\text{RMRDV}}$	4.0	—	—	ns
RXD[1:0], CRS_DV, RX_ER hold time to REF_CLK rising edge	$t_{\text{RMRDX}}$	2.0	—	—	ns

**Note:**

1. The symbols used for timing specifications follow the pattern of  $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$  for inputs and  $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$  for outputs. For example,  $t_{\text{MRDVKH}}$  symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the  $t_{\text{MRX}}$  clock reference (K) going to the high (H) state or setup time. Also,  $t_{\text{MRDXKL}}$  symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the  $t_{\text{MRX}}$  clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of  $t_{\text{MRX}}$  represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

**Table 44. JTAG AC Timing Specifications (Independent of SYSCLK)<sup>1</sup> (continued)**

Parameter	Symbol <sup>2</sup>	Min	Max	Unit	Notes
Valid times: Boundary-scan data TDO	$t_{JTKLDV}$ $t_{JTKLOV}$	4 2	20 10	ns	5
Output hold times: Boundary-scan data TDO	$t_{JTKLDX}$ $t_{JTKLOX}$	30 30	— —	ns	5
JTAG external clock to output high impedance: Boundary-scan data TDO	$t_{JTKLDZ}$ $t_{JTKLOZ}$	3 3	19 9	ns	5, 6

**Notes:**

1. All outputs are measured from the midpoint voltage of the falling/rising edge of  $t_{TCLK}$  to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50- $\Omega$  load (see Figure 29). Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
2. The symbols used for timing specifications follow the pattern of  $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)(reference)(state)}$  for inputs and  $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$  for outputs. For example,  $t_{JTDVVKH}$  symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the  $t_{JTG}$  clock reference (K) going to the high (H) state or setup time. Also,  $t_{JTDXKH}$  symbolizes JTAG timing (JT) with respect to the time data input signals (D) went invalid (X) relative to the  $t_{JTG}$  clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
3.  $\overline{TRST}$  is an asynchronous level sensitive signal. The setup time is for test purposes only.
4. Non-JTAG signal input timing with respect to  $t_{TCLK}$ .
5. Non-JTAG signal output timing with respect to  $t_{TCLK}$ .
6. Guaranteed by design.

Figure 29 provides the AC test load for TDO and the boundary-scan outputs.

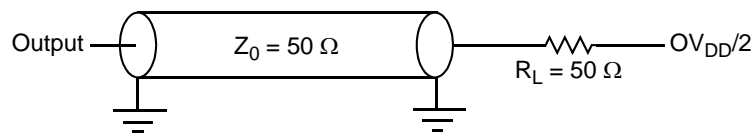
**Figure 29. AC Test Load for the JTAG Interface**

Figure 30 provides the JTAG clock input timing diagram.

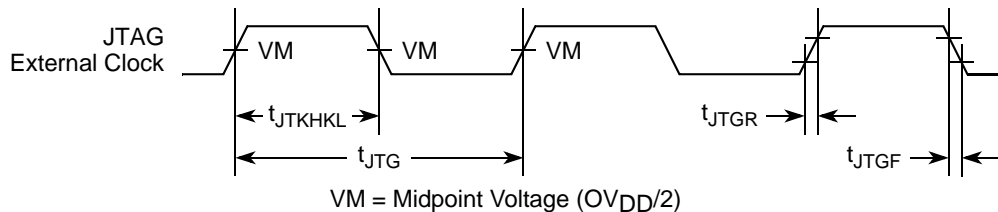
**Figure 30. JTAG Clock Input Timing Diagram**

Table 46. I<sup>2</sup>C AC Electrical Specifications (continued)

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Noise margin at the LOW level for each connected device (including hysteresis)	$V_{NL}$	$0.1 \times OV_{DD}$	—	V	—
Noise margin at the HIGH level for each connected device (including hysteresis)	$V_{NH}$	$0.2 \times OV_{DD}$	—	V	—

**Notes:**

- The symbols used for timing specifications follow the pattern of  $t_{(\text{first two letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$  for inputs and  $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$  for outputs. For example,  $t_{I2DVKH}$  symbolizes I<sup>2</sup>C timing (I2) with respect to the time data input signals (D) reach the valid state (V) relative to the  $t_{I2C}$  clock reference (K) going to the high (H) state or setup time. Also,  $t_{I2SXKL}$  symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the start condition (S) went invalid (X) relative to the  $t_{I2C}$  clock reference (K) going to the low (L) state or hold time. Also,  $t_{I2PVKH}$  symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the stop condition (P) reaching the valid state (V) relative to the  $t_{I2C}$  clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- As a transmitter, the device provides a delay time of at least 300 ns for the SDA signal (see the  $V_{IH}(\text{min})$  of the SCL signal) to bridge the undefined region of the falling edge of SCL to avoid unintended generation of Start or Stop condition. When the device acts as the I<sup>2</sup>C bus master while transmitting, the device drives both SCL and SDA. As long as the load on SCL and SDA are balanced, the device would not cause unintended generation of Start or Stop condition. Therefore, the 300 ns SDA output delay time is not a concern. If, under some rare condition, the 300 ns SDA output delay time is required for the device as a transmitter, the following setting is recommended for the FDR bit field of the I2CFDR register to ensure both the desired I<sup>2</sup>C SCL clock frequency and SDA output delay time are achieved, assuming that the desired I<sup>2</sup>C SCL clock frequency is 400 kHz and the Digital Filter Sampling Rate Register (I2CDFSRR) is programmed with its default setting of 0x10 (decimal 16):

I <sup>2</sup> C source clock frequency	333 MHz	266 MHz	200 MHz	133 MHz
FDR bit setting	0x2A	0x05	0x26	0x00
Actual FDR divider selected	896	704	512	384
Actual I <sup>2</sup> C SCL frequency generated	371 kHz	378 kHz	390 kHz	346 kHz

For the detail of I<sup>2</sup>C frequency calculation, see *Determining the I<sup>2</sup>C Frequency Divider Ratio for SCL* (AN2919). Note that the I<sup>2</sup>C source clock frequency is half of the CCB clock frequency for the device.
- The maximum  $t_{I2DXKL}$  has only to be met if the device does not stretch the LOW period ( $t_{I2CL}$ ) of the SCL signal.
- Guaranteed by design.

Figure 33 provides the AC test load for the I<sup>2</sup>C.

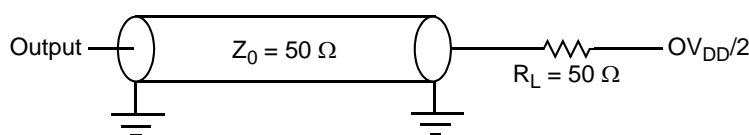
Figure 33. I<sup>2</sup>C AC Test Load



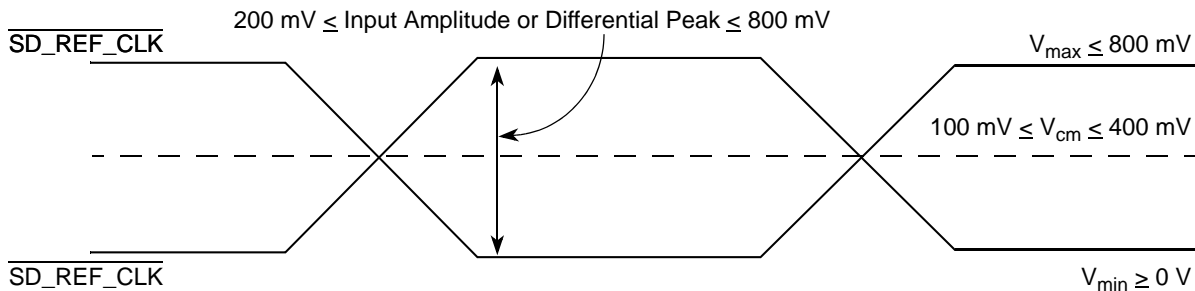
Table 54. PCI-X AC Timing Specifications at 133 MHz (continued)

Parameter	Symbol	Min	Max	Unit	Notes
$\overline{\text{HRESET}}$ to PCI-X initialization pattern hold time	$t_{\text{PCRHX}}$	0	50	ns	6, 12

**Notes:**

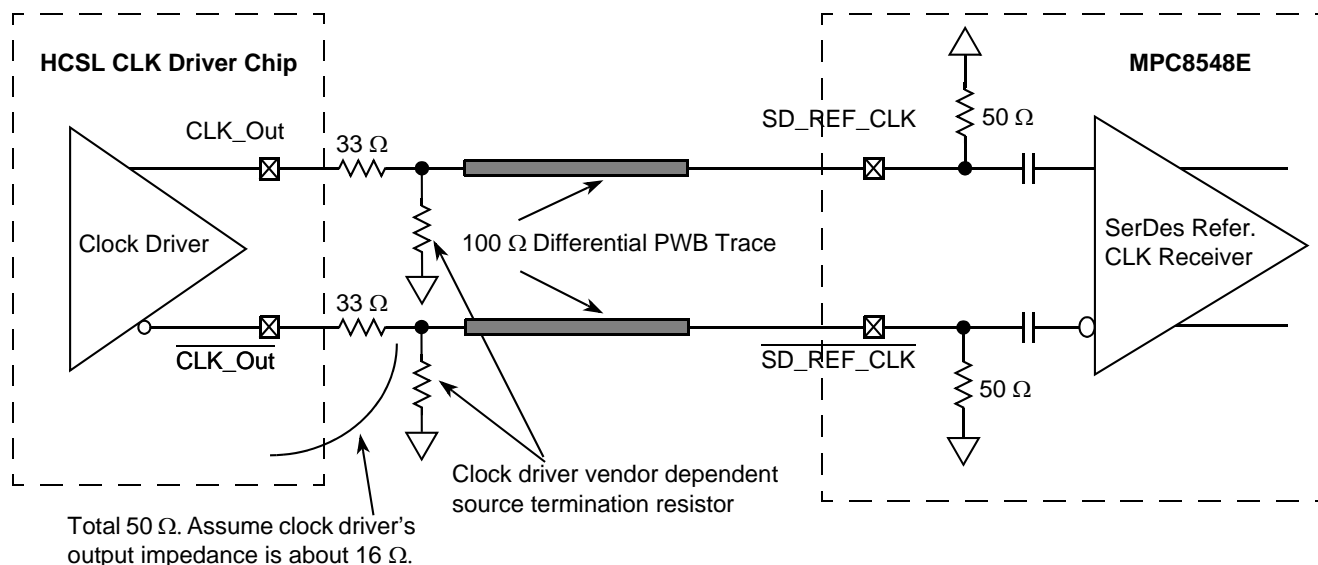
1. See the timing measurement conditions in the *PCI-X 1.0a Specification*.
2. Minimum times are measured at the package pin (not the test point). Maximum times are measured with the test point and load circuit.
3. Setup time for point-to-point signals applies to  $\overline{\text{REQ}}$  and  $\overline{\text{GNT}}$  only. All other signals are bused.
4. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
5. Setup time applies only when the device is not driving the pin. Devices cannot drive and receive signals at the same time.
6. Maximum value is also limited by delay to the first transaction (time for  $\overline{\text{HRESET}}$  high to first configuration access,  $t_{\text{PCRHFV}}$ ). The PCI-X initialization pattern control signals after the rising edge of  $\overline{\text{HRESET}}$  must be negated no later than two clocks before the first  $\overline{\text{FRAME}}$  and must be floated no later than one clock before  $\overline{\text{FRAME}}$  is asserted.
7. A PCI-X device is permitted to have the minimum values shown for  $t_{\text{PCKHOV}}$  and  $t_{\text{CYC}}$  only in PCI-X mode. In conventional mode, the device must meet the requirements specified in PCI 2.2 for the appropriate clock frequency.
8. Device must meet this specification independent of how many outputs switch simultaneously.
9. The timing parameter  $t_{\text{PCIVKH}}$  is a minimum of 1.4 ns rather than the minimum of 1.2 ns in the *PCI-X 1.0a Specification*.
10. The timing parameter  $t_{\text{PCRHFV}}$  is a minimum of 10 clocks rather than the minimum of 5 clocks in the *PCI-X 1.0a Specification*.
11. Guaranteed by characterization.
12. Guaranteed by design.

- The input amplitude of the differential clock must be between 400 and 1600 mV differential peak-peak (or between 200 and 800 mV differential peak). In other words, each signal wire of the differential pair must have a single-ended swing less than 800 mV and greater than 200 mV. This requirement is the same for both external DC- or AC-coupled connection.
- For external DC-coupled connection, as described in [Section 16.2.1, “SerDes Reference Clock Receiver Characteristics,”](#) the maximum average current requirements sets the requirement for average voltage (common mode voltage) to be between 100 and 400 mV. [Figure 40](#) shows the SerDes reference clock input requirement for DC-coupled connection scheme.
- For external AC-coupled connection, there is no common mode voltage requirement for the clock driver. Since the external AC-coupling capacitor blocks the DC level, the clock driver and the SerDes reference clock receiver operate in different command mode voltages. The SerDes reference clock receiver in this connection scheme has its common mode voltage set to SGND\_SRDSn. Each signal wire of the differential inputs is allowed to swing below and above the command mode voltage (SGND\_SRDSn). [Figure 41](#) shows the SerDes reference clock input requirement for AC-coupled connection scheme.
- Single-ended mode
  - The reference clock can also be single-ended. The SD\_REF\_CLK input amplitude (single-ended swing) must be between 400 and 800 mV peak-to-peak (from  $V_{min}$  to  $V_{max}$ ) with  $\overline{SD\_REF\_CLK}$  either left unconnected or tied to ground.
  - The  $\overline{SD\_REF\_CLK}$  input average voltage must be between 200 and 400 mV. [Figure 42](#) shows the SerDes reference clock input requirement for single-ended signaling mode.
  - To meet the input amplitude requirement, the reference clock inputs might need to be DC- or AC-coupled externally. For the best noise performance, the reference of the clock could be DC- or AC-coupled into the unused phase ( $\overline{SD\_REF\_CLK}$ ) through the same source impedance as the clock input ( $\overline{SD\_REF\_CLK}$ ) in use.



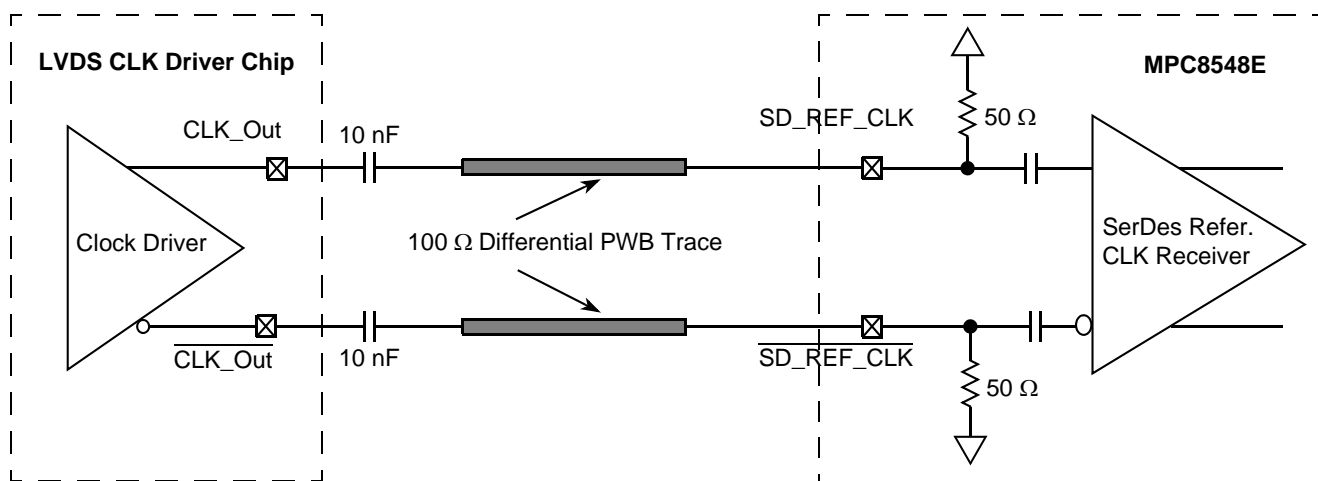
**Figure 40. Differential Reference Clock Input DC Requirements (External DC-Coupled)**

Figure 43 shows the SerDes reference clock connection reference circuits for HCSL type clock driver. It assumes that the DC levels of the clock driver chip is compatible with SerDes reference clock input's DC requirement.



**Figure 43. DC-Coupled Differential Connection with HCSL Clock Driver (Reference Only)**

Figure 44 shows the SerDes reference clock connection reference circuits for LVDS type clock driver. Since LVDS clock driver's common mode voltage is higher than the SerDes reference clock input's allowed range (100–400 mV), AC-coupled connection scheme must be used. It assumes the LVDS output driver features 50-Ω termination resistor. It also assumes that the LVDS transmitter establishes its own common mode level without relying on the receiver or other external component.



**Figure 44. AC-Coupled Differential Connection with LVDS Clock Driver (Reference Only)**

Figure 45 shows the SerDes reference clock connection reference circuits for LVPECL type clock driver. Since LVPECL driver's DC levels (both common mode voltages and output swing) are incompatible with the SerDes reference clock input's DC requirement, AC-coupling must be used. Figure 45 assumes that the LVPECL clock driver's output impedance is 50 Ω. R1 is used to DC-bias the LVPECL outputs prior

**Table 60. Short Run Transmitter AC Timing Specifications—2.5 GBaud**

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output voltage	$V_O$	−0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	$V_{DIFFPP}$	500	1000	mV p-p	—
Deterministic jitter	$J_D$	—	0.17	UI p-p	—
Total jitter	$J_T$	—	0.35	UI p-p	—
Multiple output skew	$S_{MO}$	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit interval	UI	400	400	ps	±100 ppm

**Table 61. Short Run Transmitter AC Timing Specifications—3.125 GBaud**

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output voltage	$V_O$	−0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	$V_{DIFFPP}$	500	1000	mVp-p	—
Deterministic jitter	$J_D$	—	0.17	UI p-p	—
Total jitter	$J_T$	—	0.35	UI p-p	—
Multiple output skew	$S_{MO}$	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit interval	UI	320	320	ps	±100 ppm

**Table 62. Long Run Transmitter AC Timing Specifications—1.25 GBaud**

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output voltage	$V_O$	−0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	$V_{DIFFPP}$	800	1600	mVp-p	—
Deterministic jitter	$J_D$	—	0.17	UI p-p	—
Total jitter	$J_T$	—	0.35	UI p-p	—
Multiple output skew	$S_{MO}$	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit interval	UI	800	800	ps	±100 ppm

components are included in this requirement. The reference impedance for return loss measurements is 100-Ω resistive for differential return loss and 25-Ω resistive for common mode.

**Table 66. Receiver AC Timing Specifications—1.25 GBaud**

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Differential input voltage	$V_{IN}$	200	1600	mVp-p	Measured at receiver
Deterministic jitter tolerance	$J_D$	0.37	—	UI p-p	Measured at receiver
Combined deterministic and random jitter tolerance	$J_{DR}$	0.55	—	UI p-p	Measured at receiver
Total jitter tolerance <sup>1</sup>	$J_T$	0.65	—	UI p-p	Measured at receiver
Multiple input skew	$S_{MI}$	—	24	ns	Skew at the receiver input between lanes of a multilane link
Bit error rate	BER	—	$10^{-12}$	—	—
Unit interval	UI	800	800	ps	±100 ppm

**Note:**

1. Total jitter is composed of three components, deterministic jitter, random jitter, and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of [Figure 53](#). The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk, and other variable system effects.

**Table 67. Receiver AC Timing Specifications—2.5 GBaud**

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Differential input voltage	$V_{IN}$	200	1600	mVp-p	Measured at receiver
Deterministic jitter tolerance	$J_D$	0.37	—	UI p-p	Measured at receiver
Combined deterministic and random jitter tolerance	$J_{DR}$	0.55	—	UI p-p	Measured at receiver
Total jitter tolerance <sup>1</sup>	$J_T$	0.65	—	UI p-p	Measured at receiver
Multiple input skew	$S_{MI}$	—	24	ns	Skew at the receiver input between lanes of a multilane link
Bit error rate	BER	—	$10^{-12}$	—	—
Unit interval	UI	400	400	ps	±100 ppm

**Note:**

1. Total jitter is composed of three components, deterministic jitter, random jitter, and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of [Figure 53](#). The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk, and other variable system effects.

**Table 68. Receiver AC Timing Specifications—3.125 GBaud**

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Differential input voltage	$V_{IN}$	200	1600	mVp-p	Measured at receiver
Deterministic jitter tolerance	$J_D$	0.37	—	UI p-p	Measured at receiver
Combined deterministic and random jitter tolerance	$J_{DR}$	0.55	—	UI p-p	Measured at receiver
Total jitter tolerance <sup>1</sup>	$J_T$	0.65	—	UI p-p	Measured at receiver
Multiple input skew	$S_{MI}$	—	22	ns	Skew at the receiver input between lanes of a multilane link
Bit error rate	BER	—	$10^{-12}$		—
Unit interval	UI	320	320	ps	$\pm 100$ ppm

**Note:**

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 53. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

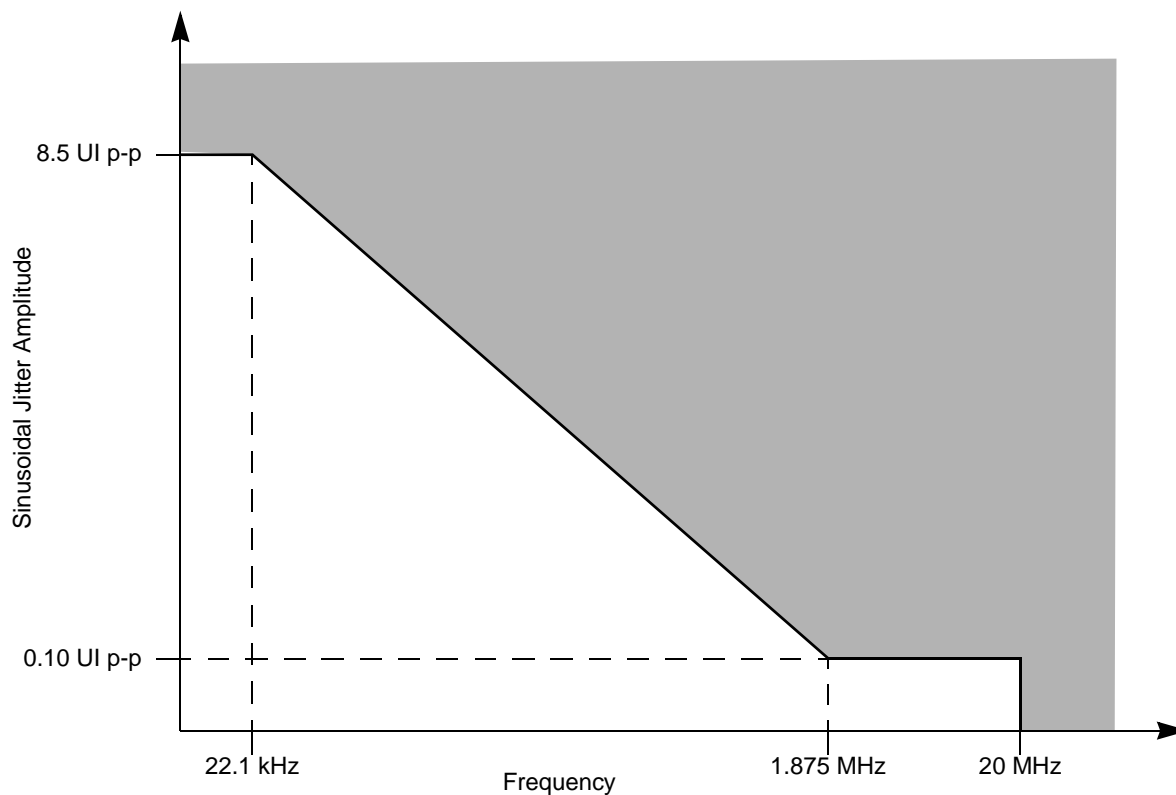
**Figure 53. Single Frequency Sinusoidal Jitter Limits**

Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
<b>Three-Speed Ethernet Controller (Gigabit Ethernet 2)</b>				
TSEC2_RXD[7:0]	P2, R2, N1, N2, P3, M2, M1, N3	I	LV <sub>DD</sub>	—
TSEC2_TXD[7:0]	N9, N10, P8, N7, R9, N5, R8, N6	O	LV <sub>DD</sub>	5, 9, 33
TSEC2_COL	P1	I	LV <sub>DD</sub>	—
TSEC2_CRS	R6	I/O	LV <sub>DD</sub>	20
TSEC2_GTX_CLK	P6	O	LV <sub>DD</sub>	
TSEC2_RX_CLK	N4	I	LV <sub>DD</sub>	—
TSEC2_RX_DV	P5	I	LV <sub>DD</sub>	—
TSEC2_RX_ER	R1	I	LV <sub>DD</sub>	—
TSEC2_TX_CLK	P10	I	LV <sub>DD</sub>	—
TSEC2_TX_EN	P7	O	LV <sub>DD</sub>	30
TSEC2_TX_ER	R10	O	LV <sub>DD</sub>	5, 9, 33
<b>Three-Speed Ethernet Controller (Gigabit Ethernet 3)</b>				
TSEC3_TXD[3:0]	V8, W10, Y10, W7	O	TV <sub>DD</sub>	5, 9, 29
TSEC3_RXD[3:0]	Y1, W3, W5, W4	I	TV <sub>DD</sub>	—
TSEC3_GTX_CLK	W8	O	TV <sub>DD</sub>	—
TSEC3_RX_CLK	W2	I	TV <sub>DD</sub>	—
TSEC3_RX_DV	W1	I	TV <sub>DD</sub>	—
TSEC3_RX_ER	Y2	I	TV <sub>DD</sub>	—
TSEC3_TX_CLK	V10	I	TV <sub>DD</sub>	—
TSEC3_TX_EN	V9	O	TV <sub>DD</sub>	30
<b>Three-Speed Ethernet Controller (Gigabit Ethernet 4)</b>				
TSEC4_TXD[3:0]/TSEC3_TXD[7:4]	AB8, Y7, AA7, Y8	O	TV <sub>DD</sub>	1, 5, 9, 29
TSEC4_RXD[3:0]/TSEC3_RXD[7:4]	AA1, Y3, AA2, AA4	I	TV <sub>DD</sub>	1
TSEC4_GTX_CLK	AA5	O	TV <sub>DD</sub>	—
TSEC4_RX_CLK/TSEC3_COL	Y5	I	TV <sub>DD</sub>	1
TSEC4_RX_DV/TSEC3_CRS	AA3	I/O	TV <sub>DD</sub>	1, 31
TSEC4_TX_EN/TSEC3_TX_ER	AB6	O	TV <sub>DD</sub>	1, 30
<b>DUART</b>				
UART_CTS[0:1]	AB3, AC5	I	OV <sub>DD</sub>	—
UART_RTS[0:1]	AC6, AD7	O	OV <sub>DD</sub>	—
UART_SIN[0:1]	AB5, AC7	I	OV <sub>DD</sub>	—
UART_SOUT[0:1]	AB7, AD8	O	OV <sub>DD</sub>	—

Table 73. MPC8545E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
SD_TX[0:3]	M23, N21, P23, R21	O	XV <sub>DD</sub>	—
Reserved	W26, Y28, AA26, AB28	—	—	40
Reserved	W25, Y27, AA25, AB27	—	—	40
Reserved	U20, V22, W20, Y22	—	—	15
Reserved	U21, V23, W21, Y23	—	—	15
SD_PLL_TPD	U28	O	XV <sub>DD</sub>	24
SD_REF_CLK	T28	I	XV <sub>DD</sub>	—
SD_REF_CLK	T27	I	XV <sub>DD</sub>	—
Reserved	AC1, AC3	—	—	2
Reserved	M26, V28	—	—	32
Reserved	M25, V27	—	—	34
Reserved	M20, M21, T22, T23	—	—	38
<b>General-Purpose Output</b>				
GPOUT[24:31]	K26, K25, H27, G28, H25, J26, K24, K23	O	BV <sub>DD</sub>	—
<b>System Control</b>				
HRESET	AG17	I	OV <sub>DD</sub>	—
HRESET_REQ	AG16	O	OV <sub>DD</sub>	29
SRESET	AG20	I	OV <sub>DD</sub>	—
CKSTP_IN	AA9	I	OV <sub>DD</sub>	—
CKSTP_OUT	AA8	O	OV <sub>DD</sub>	2, 4
<b>Debug</b>				
TRIG_IN	AB2	I	OV <sub>DD</sub>	—
TRIG_OUT/READY/QUIESCE	AB1	O	OV <sub>DD</sub>	6, 9, 19, 29
MSRCID[0:1]	AE4, AG2	O	OV <sub>DD</sub>	5, 6, 9
MSRCID[2:4]	AF3, AF1, AF2	O	OV <sub>DD</sub>	6, 19, 29
MDVAL	AE5	O	OV <sub>DD</sub>	6
CLK_OUT	AE21	O	OV <sub>DD</sub>	11
<b>Clock</b>				
RTC	AF16	I	OV <sub>DD</sub>	—
SYSCLK	AH17	I	OV <sub>DD</sub>	—
<b>JTAG</b>				
TCK	AG28	I	OV <sub>DD</sub>	—
TDI	AH28	I	OV <sub>DD</sub>	12



Table 74. MPC8543E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
$\overline{\text{MWE}}$	E7	O	GV <sub>DD</sub>	—
$\overline{\text{MCAS}}$	H7	O	GV <sub>DD</sub>	—
$\overline{\text{MRAS}}$	L8	O	GV <sub>DD</sub>	—
MCKE[0:3]	F10, C10, J11, H11	O	GV <sub>DD</sub>	11
$\overline{\text{MCS}}$ [0:3]	K8, J8, G8, F8	O	GV <sub>DD</sub>	—
MCK[0:5]	H9, B15, G2, M9, A14, F1	O	GV <sub>DD</sub>	—
$\overline{\text{MCK}}$ [0:5]	J9, A15, G1, L9, B14, F2	O	GV <sub>DD</sub>	—
MODT[0:3]	E6, K6, L7, M7	O	GV <sub>DD</sub>	—
MDIC[0:1]	A19, B19	I/O	GV <sub>DD</sub>	36
<b>Local Bus Controller Interface</b>				
LAD[0:31]	E27, B20, H19, F25, A20, C19, E28, J23, A25, K22, B28, D27, D19, J22, K20, D28, D25, B25, E22, F22, F21, C25, C22, B23, F20, A23, A22, E19, A21, D21, F19, B21	I/O	BV <sub>DD</sub>	—
LDP[0:3]	K21, C28, B26, B22	I/O	BV <sub>DD</sub>	—
LA[27]	H21	O	BV <sub>DD</sub>	5, 9
LA[28:31]	H20, A27, D26, A28	O	BV <sub>DD</sub>	5, 7, 9
$\overline{\text{LCS}}$ [0:4]	J25, C20, J24, G26, A26	O	BV <sub>DD</sub>	—
$\overline{\text{LCS5/DMA\_DREQ2}}$	D23	I/O	BV <sub>DD</sub>	1
$\overline{\text{LCS6/DMA\_DACK2}}$	G20	O	BV <sub>DD</sub>	1
$\overline{\text{LCS7/DMA\_DDONE2}}$	E21	O	BV <sub>DD</sub>	1
$\overline{\text{LWE0/LBS0/LSDDQM}}[0]$	G25	O	BV <sub>DD</sub>	5, 9
$\overline{\text{LWE1/LBS1/LSDDQM}}[1]$	C23	O	BV <sub>DD</sub>	5, 9
$\overline{\text{LWE2/LBS2/LSDDQM}}[2]$	J21	O	BV <sub>DD</sub>	5, 9
$\overline{\text{LWE3/LBS3/LSDDQM}}[3]$	A24	O	BV <sub>DD</sub>	5, 9
LALE	H24	O	BV <sub>DD</sub>	5, 8, 9
LBCTL	G27	O	BV <sub>DD</sub>	5, 8, 9
LGPL0/LSDA10	F23	O	BV <sub>DD</sub>	5, 9
LGPL1/LSDWE	G22	O	BV <sub>DD</sub>	5, 9
LGPL2/LOE/LSDRAS	B27	O	BV <sub>DD</sub>	5, 8, 9
LGPL3/LSDCAS	F24	O	BV <sub>DD</sub>	5, 9
LGPL4/LGTA/LUPWAIT/LPBSE	H23	I/O	BV <sub>DD</sub>	—
LGPL5	E26	O	BV <sub>DD</sub>	5, 9
LCKE	E24	O	BV <sub>DD</sub>	—
LCLK[0:2]	E23, D24, H22	O	BV <sub>DD</sub>	—

Table 74. MPC8543E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
IIC1_SDA	AG21	I/O	OV <sub>DD</sub>	4, 27
IIC2_SCL	AG15	I/O	OV <sub>DD</sub>	4, 27
IIC2_SDA	AG14	I/O	OV <sub>DD</sub>	4, 27
<b>SerDes</b>				
SD_RX[0:7]	M28, N26, P28, R26, W26, Y28, AA26, AB28	I	XV <sub>DD</sub>	—
$\overline{\text{SD\_RX}}[0:7]$	M27, N25, P27, R25, W25, Y27, AA25, AB27	I	XV <sub>DD</sub>	—
SD_TX[0:7]	M22, N20, P22, R20, U20, V22, W20, Y22	O	XV <sub>DD</sub>	—
$\overline{\text{SD\_TX}}[0:7]$	M23, N21, P23, R21, U21, V23, W21, Y23	O	XV <sub>DD</sub>	—
SD_PLL_TPD	U28	O	XV <sub>DD</sub>	24
SD_REF_CLK	T28	I	XV <sub>DD</sub>	—
$\overline{\text{SD\_REF\_CLK}}$	T27	I	XV <sub>DD</sub>	—
Reserved	AC1, AC3	—	—	2
Reserved	M26, V28	—	—	32
Reserved	M25, V27	—	—	34
Reserved	M20, M21, T22, T23	—	—	38
<b>General-Purpose Output</b>				
GPOUT[24:31]	K26, K25, H27, G28, H25, J26, K24, K23	O	BV <sub>DD</sub>	—
<b>System Control</b>				
$\overline{\text{HRESET}}$	AG17	I	OV <sub>DD</sub>	—
$\overline{\text{HRESET\_REQ}}$	AG16	O	OV <sub>DD</sub>	29
$\overline{\text{SRESET}}$	AG20	I	OV <sub>DD</sub>	—
$\overline{\text{CKSTP\_IN}}$	AA9	I	OV <sub>DD</sub>	—
$\overline{\text{CKSTP\_OUT}}$	AA8	O	OV <sub>DD</sub>	2, 4
<b>Debug</b>				
TRIG_IN	AB2	I	OV <sub>DD</sub>	—
TRIG_OUT/READY/QUIESCE	AB1	O	OV <sub>DD</sub>	6, 9, 19, 29
MSRCID[0:1]	AE4, AG2	O	OV <sub>DD</sub>	5, 6, 9
MSRCID[2:4]	AF3, AF1, AF2	O	OV <sub>DD</sub>	6, 19, 29
MDVAL	AE5	O	OV <sub>DD</sub>	6
CLK_OUT	AE21	O	OV <sub>DD</sub>	11
<b>Clock</b>				
RTC	AF16	I	OV <sub>DD</sub>	—
SYSClk	AH17	I	OV <sub>DD</sub>	—

## 20.3 e500 Core PLL Ratio

This table describes the clock ratio between the e500 core complex bus (CCB) and the e500 core clock. This ratio is determined by the binary value of LBCTL, LALE, and LGPL2 at power up, as shown in this table.

**Table 82. e500 Core to CCB Clock Ratio**

Binary Value of LBCTL, LALE, LGPL2 Signals	e500 core:CCB Clock Ratio	Binary Value of LBCTL, LALE, LGPL2 Signals	e500 core:CCB Clock Ratio
000	4:1	100	2:1
001	9:2	101	5:2
010	Reserved	110	3:1
011	3:2	111	7:2

## 20.4 Frequency Options

**Table 83** This table shows the expected frequency values for the platform frequency when using a CCB clock to SYSCLK ratio in comparison to the memory bus clock speed.

**Table 83. Frequency Options of SYSCLK with Respect to Memory Bus Speeds**

CCB to SYSCLK Ratio	SYSCLK (MHz)								
	16.66	25	33.33	41.66	66.66	83	100	111	133.33
	Platform/CCB Frequency (MHz)								
2									
3								333	400
4						333	400	445	533
5					333	415	500		
6					400	500			
8				333	533				
9				375					
10			333	417					
12			400	500					
16		400	533						
20	333	500							

**Note:** Due to errata Gen 13 the max sys clk frequency must not exceed 100 MHz if the core clk frequency is below 1200 MHz.

The platform PLL ratio and e500 PLL ratio configuration pins are not equipped with these default pull-up devices.

## 22.9 JTAG Configuration Signals

Correct operation of the JTAG interface requires configuration of a group of system control pins as demonstrated in [Figure 63](#). Care must be taken to ensure that these pins are maintained at a valid deasserted state under normal operating conditions as most have asynchronous behavior and spurious assertion gives unpredictable results.

Boundary-scan testing is enabled through the JTAG interface signals. The  $\overline{\text{TRST}}$  signal is optional in the IEEE 1149.1 specification, but it is provided on all processors built on Power Architecture technology. The device requires  $\overline{\text{TRST}}$  to be asserted during power-on reset flow to ensure that the JTAG boundary logic does not interfere with normal chip operation. While the TAP controller can be forced to the reset state using only the TCK and TMS signals, generally systems assert  $\overline{\text{TRST}}$  during the power-on reset flow. Simply tying  $\overline{\text{TRST}}$  to  $\overline{\text{HRESET}}$  is not practical because the JTAG interface is also used for accessing the common on-chip processor (COP), which implements the debug interface to the chip.

The COP function of these processors allow a remote computer system (typically, a PC with dedicated hardware and debugging software) to access and control the internal operations of the processor. The COP interface connects primarily through the JTAG port of the processor, with some additional status monitoring signals. The COP port requires the ability to independently assert  $\overline{\text{HRESET}}$  or  $\overline{\text{TRST}}$  in order to fully control the processor. If the target system has independent reset sources, such as voltage monitors, watchdog timers, power supply failures, or push-button switches, then the COP reset signals must be merged into these signals with logic.

The arrangement shown in [Figure 63](#) allows the COP port to independently assert  $\overline{\text{HRESET}}$  or  $\overline{\text{TRST}}$ , while ensuring that the target can drive  $\overline{\text{HRESET}}$  as well.

The COP interface has a standard header, shown in [Figure 62](#), for connection to the target system, and is based on the 0.025" square-post, 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

The COP header adds many benefits such as breakpoints, watchpoints, register and memory examination/modification, and other standard debugger features. An inexpensive option can be to leave the COP header unpopulated until needed.

There is no standardized way to number the COP header; so emulator vendors have issued many different pin numbering schemes. Some COP headers are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom. Still others number the pins counter-clockwise from pin 1 (as with an IC). Regardless of the numbering scheme, the signal placement recommended in [Figure 62](#) is common to all known emulators.

### 22.9.1 Termination of Unused Signals

Freescale recommends the following connections, when the JTAG interface and COP header are not used:

- $\overline{\text{TRST}}$  must be tied to  $\overline{\text{HRESET}}$  through a 0 k $\Omega$  isolation resistor so that it is asserted when the system reset signal ( $\overline{\text{HRESET}}$ ) is asserted, ensuring that the JTAG scan chain is initialized during the power-on reset flow. Freescale recommends that the COP header be designed into the system

as shown in Figure 63. If this is not possible, the isolation resistor allows future access to  $\overline{\text{TRST}}$  in case a JTAG interface may need to be wired onto the system in future debug situations.

- No pull-up/pull-down is required for TDI, TMS, TDO, or TCK.

COP_TDO	1	2	NC
COP_TDI	3	4	$\overline{\text{COP\_TRST}}$
COP_RUN/STOP	5	6	COP_VDD_SENSE
COP_TCK	7	8	$\overline{\text{COP\_CHKSTP\_IN}}$
COP_TMS	9	10	NC
$\overline{\text{COP\_SRESET}}$	11	12	NC
$\overline{\text{COP\_HRESET}}$	13	KEY No pin	
$\overline{\text{COP\_CHKSTP\_OUT}}$	15	16	GND

**Figure 62. COP Connector Physical Pinout**